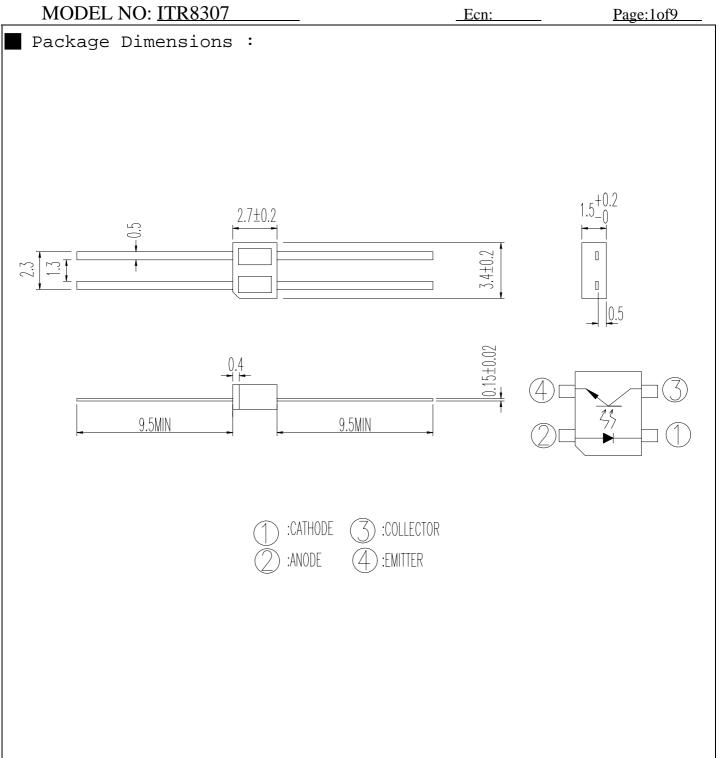


Device Number: <u>DRX-083-025</u> REV: <u>2.0</u>



Office: NO 25, Lane. 76, Chung Yang Rd., Sec. 3, Tucheng, Taipei 236, Taiwan, R.O.C.

TEL: 886-2-2267-2000,2267-9936(22Lines)

FAX: 886-2-2267-6189

http://www.everlight.com



MODEL NO: ITR8307

### EVERLIGHT ELECTRONICS CO, LTD.

Device Number: <u>DRX-083-025</u> REV: <u>2.0</u>
<u>Ecn:</u> Page:2of9

#### ONotes:

- 1.All dimensions are in millimeters.
- 2.General Tolerance: ± 0.15mm.
- 3. Lead spacing is measured where the lead emerge from the package.
- 4. Above specification may be changed without notice. EVERLIGHT will reserve authority on material change for above specification.
- 5. These specification sheets include materials protected under copyright of EVERLIGHT corporation. Please don't reproduce or cause anyone to reproduce them without EVERLIGHT's consent.
- 6.When using this product , please observe the absolute maximum ratings and the instructions for use outlined in these specification sheets. EVERLIGHT assumes no responsibility for any damage resulting from use of the product which does not comply with the absolute maximum ratings and the instructions included in these specification sheets.

#### Descriptions:

ITR8307 is a light reflection switch which includes a GaAs IRLED transmitter and a NPN photo-transistor with a high photosensitive receiver for short distance, operating in the infrared range. Both components are mounted side-by-side in a plastic package.

#### Features:

- Fast response time
- High sensitivity
- Cutting wavelength  $\lambda = 840 \text{nm}$
- Thin
- Compact

#### Applications:

- Camera
- VCR
- Floppy disk driver
- Cassette type recorder
- Various microcomputer control equipment

00/03/26 02:52 PM 2 8307



MODEL NO: ITR8307

# EVERLIGHT ELECTRONICS CO, LTD.

 Device Number: DRX-083-025
 REV: 2.0

 Ecn:
 Page:30f9

### Absolute Maximum Ratings (Ta=25°C)

	Parameter	Symbol	Ratings	Unit
	Power Dissipation at(or below) 25°C Free Air Temperature	Pd	75	mW
Input	Reverse Voltage	$V_R$	5	V
	Forward Current	$I_{F}$	50	mA
	Peak Forward Current Pulse width $\leq 100 \mu$ s, Duty cycle=1%	$I_{\text{FP}}$	1	A
	Collector Power Dissipation	$P_{\rm C}$	75	mW
Output	Collector Current	$I_{C}$	50	mA
	Collector-Emitter Voltage	B V <sub>CEO</sub>	30	V
	Emitter-Collector Voltage	B V <sub>ECO</sub>	5	V
Operating Temperature		Topr	-25~+85	$^{\circ}\!\mathbb{C}$
Storage Temperature		Tstg	-40~+85	$^{\circ}\!\mathbb{C}$
Lead Soldering Temperature (1/16 inch from body for 5 seconds)		Tsol	260	°C

(\*1)  $tw=100 \mu sec.$ , T=10 msec. (\*2) t=5 Sec

### Electro-Optical Characteristics (Ta=25°C)

	Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
	Forward Voltage	$V_{\scriptscriptstyle F}$		1.2	1.6	V	$I_F=20mA$
Input	Reverse Current	$I_{\scriptscriptstyle R}$			10	$\mu$ A	$V_R=5V$
	Peak Wavelength	λ <sub>P</sub>		940		nm	
	View Angle	2€1/2		110		Deg	$I_F=20mA$
Output	Dark Current	$I_{CEO}$			100	nA	$V_{\text{CE}}=10V$
	C-E Saturation Voltage	V <sub>CE</sub> (sat)			0.4	V	$I_{C}=2mA$ $I_{B}=0.1mA$
Light Current		$I_{C}(ON)$	0.1			mA	$V_{CE}=5V$
Leakage Current		Iceod		-	1	$\mu$ A	$I_F=20mA$
Speed	Rise time	$t_{\rm r}$		20		$\mu$ sec	$V_{CE}=2V$
	Fall time	$t_{\mathrm{f}}$		20		μsec	$I_{C}=100 \mu A$ $R_{L}=1K\Omega$



Device Number: <u>DRX-083-025</u> REV: <u>2.0</u>
<u>Ecn:</u> Page:4of9

#### MODEL NO: ITR8307

#### ■ Typical Characteristics For IR

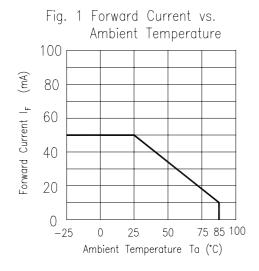


Fig. 3 Peak Emission Wavelength vs.
Ambient Temperature

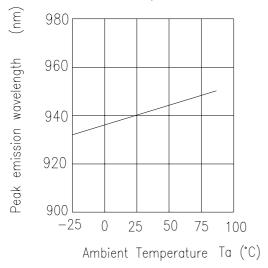


Fig. 5 Forward Voltage vs.

Ambient Temperature

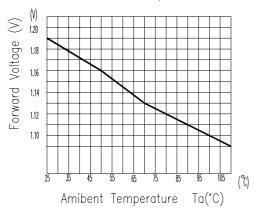


Fig. 2 Spectral Distribution

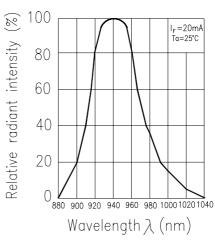


Fig. 4 Forward Current vs. Forward Voltage

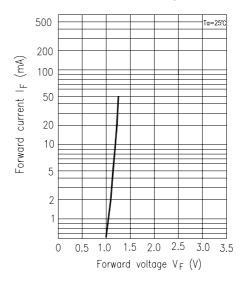
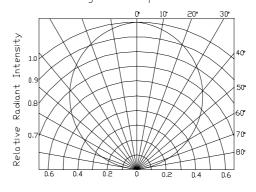


Fig. 6 Relative Radiant Intensity vs.

Angular Displacement





MODEL NO: ITR8307

## EVERLIGHT ELECTRONICS CO, LTD.

Device Number: <u>DRX-083-025</u> REV: <u>2.0</u>

Ecn: Page:50f9

#### Typical Characteristics

Fig.1 Collector Power Dissipation vs.
Ambient Temperature

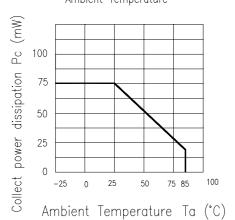


Fig. 3 Relative Collector Current vs. Ambient Temperature

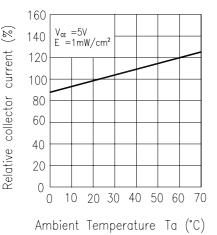


Fig.5 Spectral Sensitivity

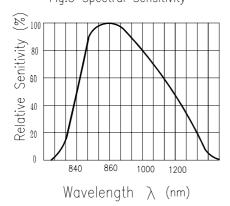


Fig.2 Collector Dark Current vs. Ambient Temperature

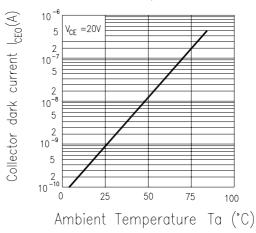


Fig.4 Collector Current vs. Irradiance

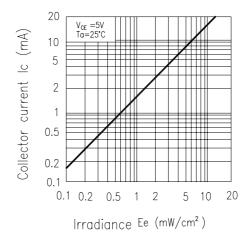
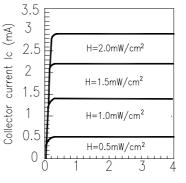


Fig.6 Collector Current vs.
Collector—emitter Voltage



Collector-emitter Voltage V cF (V)

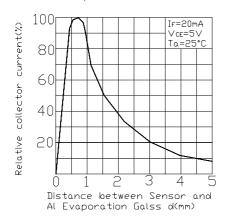


Device Number: DRX-083-025 **REV: 2.0** 

Ecn: Page:6of9

#### MODEL NO: ITR8307 ■Typical Characteristics For ITR

Fig.7 Relative Collector Current vs.
Distance between Sensor and Al Evaporation Galss



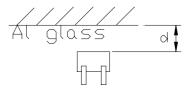
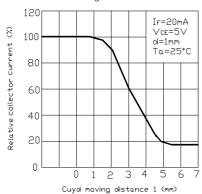


Fig.8 Relative Collector Current vs. Card Moving Distance (1)



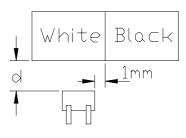
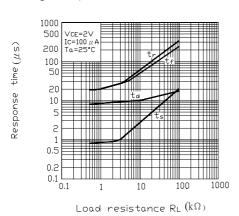
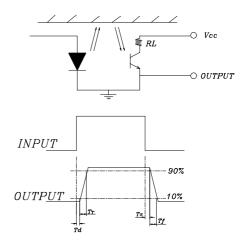


Fig.9 Response Time vs. Load Resistance







 Device Number: DRX-083-025
 REV: 2.0

 Ecn:
 Page:70f9

MODEL NO: <u>ITR8307</u>

Reliability test item and condition

The reliability of products shall be satisfied with item listed below:

Confidence level :90% LTPD:10%

Parameter	Purpose & Condition	Failure Judgement Criteria	Samples(n) Defective(c)
Temperature Cycle	Evaluates product's ability	Cinteria	n = 22, $c = 0$
1	to withstand exposure to	$I_R \ge U \times 2$	
	high temperature, low		
	temperature, and temperature		
	variation between two limit		
	temperature. Standard test	U: Upper	
	Condition:	specification	
	85°C ~25°C ~-55°C ~25°C	limit	
	$\downarrow$ $\downarrow$ $\downarrow$	L: Lower	
	30min 5min 30min 5min	specification	
	50 cycle	limit	
Thermal Shock	Evaluates product's ability to		n = 22 , c = 0
	withstand rapid temperature		
	change Standard test		
	Condition:		
	85°C ~ -55°C		
	5min (10 sec)5min		
	50cycle		
High Temperature	Evaluates product's ability to		n = 22 , c = 0
Storage	withstand prolonged storage		
	at high temperature Standard		
	test Condition:		
	Temperature : 100 $^{\circ}$ C		
	Time: 1000hrs		
Low Temperature	Evaluates product's ability to		n =22 , c=0
Storage	withstand prolonged storage		
	at low temperature Standard		
	test Condition:		
	Temperature : -55 °C		
	Time: 1000hrs		



 Device Number: DRX-083-025
 REV: 2.0

 Ecn:
 Page:8of9

MODEL NO: ITR8307 Ecn:

ъ.	D 0 G 11:	Failure	Samples(n)
Parameter	Purpose & Condition	Judgement Criteria	Defective(c)
Operating Life Test	Evaluates product's endurance		n =22 , c=0
	to prolonged electrical or	$ \begin{array}{c} I_{R} \ge U \times 2 \\ I_{C}(on) \le L \times 0.8 \end{array} $	
	temperature stresses. Standard	$V_F \ge U \times 1.2$	
	test Condition:		
	$V_{CE}=5V$		
	$I_F=20mA$	U: Upper	
	Time: 1000hrs	specification	
High Temperature	Evaluates product's ability to	limit	n =22 , c=0
	withstand prolonged storage	L: Lower	
High Humidity	at high temperature and high	specification	
	humidity. Standard test	limit	
	Condition:		
	Temperature: 85°C		
	Relative humidity:85%		
	Time: 1000hrs		
Soldering Heat	Evaluates product's ability to		n =22 , c=0
	withstand soldering heat		
	Standard test conditions		
	Solder temperature : 260±5°C		
	Solder time : 5 seconds		

#### Supplements

1.Parts

(1) Chip

Type	Material	Peak Wavelength
IR	GaAs	940 nm

Type	Material	Cutting Wavelength
PT	Silicon	840 nm

(2)Material

Туре	Lead frame	Wire	Part Package
Material	Cu	Gold	Epoxy

00/03/26 02:52 PM 8 8307



Device Number: <u>DRX-083-025</u> REV: <u>2.0</u>
DEL NO: <u>ITR8307</u> <u>Ecn:</u> <u>Page:9of9</u>

